

## **Quarterly Reliability Monitoring Results**

## Quarters: Q1/2021 to Q4/2021

Based on structural similarity

| Supplier Nexperia B.V. Name of Laboratory Assembly reliability labs |                               | User Part Number                                    |             |           |           |           |  |      |
|---------------------------------------------------------------------|-------------------------------|-----------------------------------------------------|-------------|-----------|-----------|-----------|--|------|
|                                                                     |                               | PESD5V0F1BRSF                                       |             |           |           |           |  |      |
|                                                                     |                               | Part Description                                    |             |           |           |           |  |      |
|                                                                     |                               | Nexperia DHAM Protection Std Bipolar BD package     |             |           |           |           |  |      |
|                                                                     |                               |                                                     |             |           |           |           |  | Test |
|                                                                     | TEST                          |                                                     |             |           |           |           |  |      |
|                                                                     | Pre- and Post-Stress          |                                                     |             |           |           |           |  |      |
| # 1                                                                 | Electrical Test               | Tamb = 25 °C                                        | N/A         | see below | all parts | see below |  |      |
|                                                                     |                               | MIL-STD-750-1                                       |             |           |           |           |  |      |
|                                                                     | HTRB                          | M1038 Method A                                      |             |           |           |           |  |      |
|                                                                     |                               | Tj = Tjmax, Vr = 100% of max. datasheet             |             |           |           |           |  |      |
| # 5                                                                 | Bias                          | reverse voltage                                     | 1000 hours  | 6         | 480       | 0         |  |      |
|                                                                     | тс                            | JESD22-A104                                         |             |           |           |           |  |      |
| # 7                                                                 | Temperature Cycling           | -40 °C to 125°C                                     | 1000 cycles | 67        | 5360      | 0         |  |      |
| # /                                                                 | remperature eyemig            | IESD22-A102                                         | 1000 Cycles | 07        | 3300      | 0         |  |      |
|                                                                     | AC                            | Tamb = 121 °C, RH = 100 %                           |             |           |           |           |  |      |
| # 8                                                                 | Autoclave                     | Pressure = 205 kPa (29.7 psia)                      | 96 hours    | n.a.      | n.a.      | n.a.      |  |      |
| ,, 0                                                                |                               | , ,                                                 | 30 110010   |           |           |           |  |      |
|                                                                     | HAST                          | JESD22-A110                                         |             |           |           |           |  |      |
|                                                                     | Highly Accelerated Stress     | Tamb = 130 °C, RH = 85%, VR = 80 % of               |             |           |           |           |  |      |
| # 9                                                                 | Test                          | rated reverse voltage <sup>[1]</sup>                | 1000 hours  | 67        | 5360      | 0         |  |      |
|                                                                     |                               | MIL-STD-750 Method 1037                             |             |           |           |           |  |      |
|                                                                     | IOL                           | ton = toff, devices powered to insure $\Delta Tj$ = |             |           |           |           |  |      |
| # 10                                                                | Intermittent Operating Life   | 100 °C for 15000 cycles                             | 1000 hours  | n.a.      | n.a.      | n.a.      |  |      |
|                                                                     | DCII                          | JECD22 4111                                         |             |           |           |           |  |      |
|                                                                     | RSH Resistance to Solder Heat | JESD22-A111<br>260 °C ± 5 °C                        | 10          |           |           |           |  |      |
| # 20                                                                |                               | 200 -C = 3 -C                                       | 10 s        | n.a.      | n.a.      | n.a.      |  |      |
| # 21                                                                | SD<br>Solderability           | J-STD-002                                           |             | 10        | 120       | 0         |  |      |
| # 21                                                                | Soluei ability                | J-31D-002                                           |             | 12        | 120       | 0         |  |      |

<sup>[1]</sup> The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Wafer Fab | Technology             | Quantity | Rejects | Failure Rate (FIT) | MTTF (hrs) |
|-----------|------------------------|----------|---------|--------------------|------------|
| Nexperia  |                        |          |         |                    |            |
| DHAM      | Protection Std Bipolar | 480      | 0       | 8.85               | 1.13E+08   |

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